GKS-075 355 050 A 1000

Item GKS-075-0299

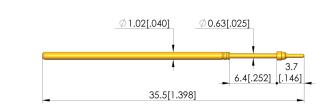


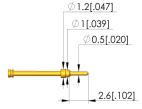


- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- · Various spring forces available as well as versions with stainless steel springs suitable for high temperatures
- Used for setting the optimum stroke conditions in the test fixture, various installation heights can be achieved by combining test probes and receptacles









General data

RoHS-compliant:

Product group: ICT / FCT (in-circuit test and function test Sub-product group: Standard stroke test probe Series: GKS-075 Grid: 1.91 mm [75.1 mil] Contacting from: Pad Magnetic: Yes Installation type: Plug-in Quick-exchange system: Yes Adjustable installation height: No Non-rotating: No Compatible receptacle(s): KS-075 -40 °C [-40 °F] Min. temperature: 80 °C [176 °F] Max. temperature:

Tip style data

Tip style: 55 bullet-nosed, special length Tip diameter: 0.5 mm [.019 in] Tip style surface: A gold Tip style material: 3 CuBe

Electrical data

Current load capacity / rated current: 3 A Typical resistance (Ri): 20 mOhm

Mechanical data

35.5 mm [1.39 in] Total length: Barrel diameter: 1.02 mm [.04 in] Maximum stroke: 6.35 mm [.25 in] Spring pre-load: 0.4 N [1.43 ozf] Collar height: Spring force at working stroke: 1 N [3.59 ozf] 4.3 mm [.169 in] Recommended working stroke:

Yes

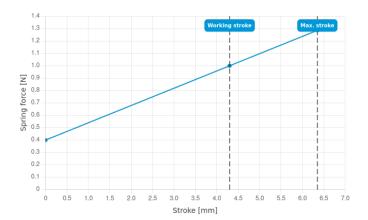
ICT/FCT TEST PROBES

Test Probe GKS-075 355 050 A 1000

Item GKS-075-0299







INGUN Prüfmittelbau GmbH

Max-Stromeyer-Straße 162 78467, Constance, Germany Phone +49 7531 8105-0 Customer hotline +49 7531 8105-888 Fax +49 7531 8105-65 info@ingun.com









Learn more about **ICT/FCT Test probes**

